



1:4 Clock Driver for Intel PCIe® Chipsets

#### Features

- Phase jitter filter for PCIe® 2.0 application
- Four Pairs of Differential Clocks
- Low skew < 50ps
- Low jitter < 50ps cycle-to-cycle
- < 1 ps additive RMS phase jitter
- Output Enable for all outputs
- Outputs tristate control via SMBus
- Programmable PLL Bandwidth
- 100 MHz PLL Mode operation
- 100 400 MHz Bypass Mode operation
- 3.3V Operation
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative.

https://www.diodes.com/quality/product-definitions/

- Packaging (Pb-free and Green):
  - □ 28-Pin SSOP (H28)
  - 28-Pin TSSOP (L28)

#### Description

The PI6C20400A is a PCIe<sup>®</sup> 2.0 compliant high-speed, low-noise differential clock buffer designed to be companion to PI6C410BS. The device distributes the differential SRC clock from PI6C410BS to four differential pairs of clock outputs either with or without PLL. The clock outputs are controlled by input selection of SRC STOP#, PWRDWN# and SMBus, SCLK and SDA. When input of either SRC\_STOP# or PWRDWN# is low, the output clocks are Tristated. When PWRDWN# is low, the SDA and SCLK inputs must be Tri-stated.

#### **Block Diagram**



Notes:

<sup>1.</sup> No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

<sup>2.</sup> See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free. 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.





# **Pin Configuration**

	28 VDD_A
SRC 🗖 2	
SRC# 🗖 3	
V <sub>SS</sub> 🗖 4	25 📮 OE_INV
VDD 🗖 5	24 📮 V <sub>DD</sub>
Ουτο 🗖 6	23 🗖 OUT3
OUT0# 🗖 7	22 📮 OUT3#
OE_0 🗖 8	21 🗖 OE_3
OUT1 🗖 9	20 🗖 OUT2
OUT1# 🗖 10	0 19 🗗 OUT2#
V <sub>DD</sub> <b>q</b> 1	1 18 📮 V <sub>DD</sub>
PLL/BYPASS# 🛛 1	2 17 📮 PLL_BW#
SCLK 🛛 1	3 16 📮 SRC_STOP#
SDA 🗖 1/	4 15 📮 PWRDWN#
	J

# **Pin Descriptions**

Pin#	Pin Name	Туре	Description
2, 3	SRC, SRC#	Input	0.7V Differential SRC input from PI6C410 clock synthesizer
8, 21	OE_0, OE_3	Input	<ul><li>3.3V LVTTL input for enabling outputs, active high.</li><li>OE_0 for OUT0 / OUT0#</li><li>OE_3 for OUT3 / OUT3#</li></ul>
25	OE_INV	Input	<ul><li>3.3V LVTTL input for inverting the OE, SRC_STOP# and PWRDWN# pins.</li><li>When 0 = same stage</li><li>When 1 = OE_0, OE_3, SRC_STOP#, PWRDWN# inverted.</li></ul>
6, 7, 9, 10, 19, 20, 22, 23	OUT[0:3] & OUT[0:3]#	Output	0.7V Differential outputs
12	PLL/BYPASS#	Input	3.3V LVTTL input for selecting fan-out of PLL operation.
13	SCLK	Input	SMBus compatible SCLOCK input
14	SDA	I/O	SMBus compatible SDATA
26	IREF	Input	External resistor connection to set the differential output current
16	SRC_STOP#	Input	3.3V LVTTL input for SRC stop, active low
17	PLL_BW#	Input	3.3V LVTTL input for selecting the PLL bandwidth
15	PWRDWN#	Input	3.3V LVTTL input for Power Down operation, active low
1, 5, 11, 18, 24	V <sub>DD</sub>	Power	3.3V Power Supply for Outputs
4	VSS	Ground	Ground for Outputs
27	VSS_A	Ground	Ground for PLL
28	VDD_A	Power	3.3V Power Supply for PLL





## Serial Data Interface (SMBus)

This part is a slave only SMBus device that supports indexed block read and indexed block write protocol using a single 7-bit address and read/write bit as shown below.

#### **Address Assignment**

A6	A5	A4	A3	A2	A1	A0	W/R
1	1	0	1	1	1	0	0/1

#### **Data Protocol**

1 bit	7 bits	1	1	8 bits	1	8 bits	1	8 bits	1	8 bits	1	1 bit
Start bit	Slave Addr	R/W	Ack	Register offset	Ack	Byte Count = N	Ack	Data Byte 0	Ack	 Data Byte N - 1	Ack	Stop bit

Notes:

1. Register offset for indicating the starting register for indexed block write and indexed block read. Byte Count in write mode cannot be 0.

#### **Data Byte 0: Control Register**

Bit	Descriptions	Туре	Power Up Condition	Output(s) Affected	Source Pin
	Outputs Mode				
0	0 = Divide by 2	RW	1 = Normal	OUT[0:3], OUT[0:3]#	NA
	1 = Normal				
	PLL/BYPASS#				
1	0 = Fanout	RW	1 = PLL	OUT[0:3], OUT[0:3]#	NA
	1 = PLL				
	PLL Bandwidth				
2	0 = High Bandwidth,	RW	1 = Low	OUT[0:3], OUT[0:3]#	NA
	1 = Low Bandwidth				
3	Reserved				NA
4	Reserved				NA
5	Reserved				NA
	SRC_STOP#				
6	0 = Driven when stopped	RW	0 = Driven when stopped	OUT[0:3], OUT[0:3]#	NA
	1 = Tristate				
	PWRDWN#				
7	0 = Driven when stopped	RW	0 = Driven when stopped	OUT[0:3], OUT[0:3]#	NA
	1 = Tristate				





#### Data Byte 1: Control Register

Bit	Descriptions	Туре	Power Up Condition	Output(s) Affected	Source Pin
0	Reserved				NA
1	OUTPUTS enable	RW	1 = Enabled	OUT0, OUT0#	NA
2	1 = Enabled 0 = Disabled	RW	1 = Enabled	OUT1, OUT1#	NA
3	Reserved				NA
4	Reserved				NA
5	OUTPUTS enable	RW	1 = Enabled	OUT2, OUT2#	NA
6	1 = Enabled 0 = Disabled	RW	1 = Enabled	OUT3, OUT3#	NA
7	Reserved				NA

## Data Byte 2: Control Register

Bit	Descriptions	Туре	Power Up Condition	Output(s) Affected	Source Pin
0	Reserved				NA
1	Allow control of OUTPUTS with	RW	0 = Free running	OUT0, OUT0#	NA
2	assertion of SRC_STOP# 0 = Free running 1 = Stopped with SRC_Stop#	RW	0 = Free running	OUT1, OUT1#	NA
3	Reserved				NA
4	Reserved				NA
5	Allow control of OUTPUTS with	RW	0 = Free running	OUT2, OUT2#	NA
6	assertion of SRC_STOP# 0 = Free running 1 = Stopped with SRC_Stop#	RW	0 = Free running	OUT3, OUT3#	NA
7	Reserved				NA





#### Data Byte 3: Control Register

Bit	Descriptions	Туре	Power Up Condition	Output(s) Affected	Source Pin
0		RW			
1		RW			
2		RW			
3	D	RW			
4	Reserved	RW			
5		RW			
6		RW			
7		RW			

#### Data Byte 4: Pericom ID Register

Bit	Descriptions	Туре	Power Up Condition	Output(s) Affected	Pin
0		R	0	NA	NA
1		R	0	NA	NA
2		R	0	NA	NA
3	Pericom ID	R	0	NA	NA
4	Periconi iD	R	0	NA	NA
5		R	1	NA	NA
6		R	0	NA	NA
7		R	0	NA	NA





## **Functionality**

PWRDWN#	OUT	OUT#	SRC_Stop#	OUT	OUT#
1	Normal	Normal	1	Normal	Normal
0	$I_{REF} \times 2$ or Float	Low	0	$I_{REF} \times 6$ or Float	Low

## Power Down (PWRDWN# assertion)



#### **Figure 1. Power Down Sequence**

#### Power Down (PWRDWN# De-assertion)



#### Figure 2. Power Down De-assert Sequence





## Current-mode Output Buffer Characteristics of OUT[0:3], OUT[0:3]#





#### **Differential Clock Buffer Characteristics**

Symbol	Minimum	Maximum		
R <sub>O</sub>	3000Ω	N/A		
R <sub>OS</sub>	unspecified	unspecified		
V <sub>OUT</sub>	N/A	850mV		

#### **Current Accuracy**

Symbol	Conditions	Configuration	Load	Min.	Max.
I <sub>OUT</sub>	$V_{DD} = 3.30 \pm 5\%$	$R_{REF} = 475\Omega \ 1\%$	Nominal test load for given	-12% I <sub>NOMI-</sub>	+12% I <sub>NOMI-</sub>
-001		$I_{REF} = 2.32 m A$	configuration	NAL	NAL

Note:

1.  $I_{NOMINAL}$  refers to the expected current based on the configuration of the device.

### **Differential Clock Output Current**

Board Target Trace/Term Z	Reference R, Iref = $V_{DD}/(3xRr)$	Output Current	V <sub>OH</sub> @ Z
100Ω	$R_{REF} = 475\Omega \ 1\%$ ,	I ( I	0.711 0.50
(100 $\Omega$ differential $\approx$ 15% coupling ratio)	$I_{REF} = 2.32 m A$	$I_{OH} = 6 \ge I_{REF}$	0.7V @ 50





### Absolute Maximum Ratings

(	Over	operating	free-air	temperature	range)
•	0.01	operating	nee un	temperature	range)

Symbol	Parameters	Min.	Max.	Units
V <sub>DD_A</sub>	3.3V Core Supply Voltage	-0.5	4.6	
V <sub>DD</sub>	3.3V I/O Supply Voltage	-0.5	4.6	V
V <sub>IH</sub>	Input High Voltage		4.6	V
V <sub>IL</sub>	Input Low Voltage	-0.5		
Ts	Storage Temperature	-65	150	°C
V <sub>ESD</sub>	ESD Protection	2000		V
Тј	Junction Temperature		125	°C

Note:

1. Stress beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device.

#### Symbol **Parameters** Condition Min. Max. Units 3.3V Core Supply Voltage V<sub>DD</sub> A 3.135 3.465 $V_{DD}$ 3.3V I/O Supply Voltage 3.135 3.465 V VIH 3.3V Input High Voltage VDD 2.0 $V_{DD} + 0.3$ 3.3V Input Low Voltage $V_{SS} - 0.3$ VIL 0.8 $0 < V_{\rm IN} < V_{\rm DD}$ Input Leakage Current -5 +5 $I_{IL}$ μA VOH 3.3V Output High Voltage $I_{OH} = -1mA$ 2.4V 3.3V Output Low Voltage VOL $I_{OL} = 1mA$ 0.4 $I_{OH} = 6 \times I_{REF}$ 12.2 $I_{OH}$ Output High Current mА $I_{REF} = 2.32 \text{mA}$ 15.6 Input Pin Capacitance 2 5 CIN pF COUT Output Pin Capacitance 6 Pin Inductance 7 Lpin nH Power Supply Current $V_{DD} = 3.465 V$ , $F_{CPU} = 100 MHz$ 90 I<sub>DD(BYPASS)</sub> (PLL Bypass) **Bypass** $V_{DD} = 3.465 V$ 100 mode Power Supply Current $I_{DD}$ mA $F_{CPU} = 100 MHz$ PLL mode 130 Power Down Current ISS Driven outputs 40 Power Down Current Tristate outputs 12 ISS °C $T_{\rm A}$ -40 85 Ambient Temperature

#### **DC Electrical Characteristics** (V<sub>DD</sub> = 3.3±5%, V<sub>DD A</sub> = 3.3±5%)





# HCSL Input (SRC, SRC#) Characteristics<sup>(1)</sup>

Temperature = T<sub>A</sub>; Supply voltages per normal operation conditions; See test circuits for the load conditions

Symbol	Parameters	Conditions	Min.	Тур.	Max.	Units
V <sub>COM</sub>	Diff. Input Common Mode Voltage		150		900	mV
V <sub>SWING</sub>	Diff. Input Swing Voltage	Peak to peak value (V <sub>IHDIF</sub> - V <sub>ILDIF)</sub>	300		1000	mV
f <sub>INBP</sub>	Input Frequency	PLL Bypass mode	100		400	MHz
f <sub>IN100</sub>	Input Frequency	PLL mode	95	100	105	MHz
f <sub>MODI-</sub> PCIe	Input SS Modulation Freq. PCIe	Allowable frequency for PCIe applications (Triangular Modulation)	30		33	kHz
f <sub>MODIN-</sub> non-PCIe	Input SS Modulation Freq. non-PCIe	Allowable frequency for non-PCIe applica- tions (Triangular Modulation)	0		46	kHz
t <sub>RF</sub>	Diff. Input Slew Rate <sup>(2)</sup>	Measured differentially	0.4			V/ns
I <sub>IN</sub>	Diff. Input Leakage Current	$V_{IN} = V_{DD}, V_{IN} = GND$	-5	0.01	5	uA
t <sub>DC</sub>	Diff. Input Duty Cycle	Measured differentially	45		55	%
tj <sub>c-c</sub>	Diff. Input Cycle to cycle jitter	Measured differentially			125	ps

#### Note:

1. Guaranteed by design and characterization, not 100% tested in production

2. Slew rate measured through +/-75mV window centered around differential zero





Symbol	Parameters	Condition	Min.	Max.	Units	Notes
T <sub>rise</sub> / T <sub>fall</sub>	Rise and Fall Time	Measured between 0.175V to 0.525V	175	700	ps	2
DT <sub>rise</sub> / DT <sub>fall</sub>	Rise and Fall Time Variation			125	ps	2
T	Draw and in a later	PLL Mode		±250	ps	
T <sub>pd</sub>	Propogation delay	Bypass Mode	2.5	6.5	ns	6
T <sub>jitter</sub>	Cycle – Cycle Jitter	OUT[0:3] & OUT[0:3]#		50	ps	3, 4
V <sub>HIGH</sub>	Voltage High including overshoot	OUT[0:3] & OUT[0:3]#	660	1150	mV	2
V <sub>LOW</sub>	Voltage Low including undershoot	OUT[0:3] & OUT[0:3]#	-300		mV	2
V <sub>cross</sub>	Absolute crossing point voltages	OUT[0:3] & OUT[0:3]#	250	550	mV	2
DV <sub>cross</sub>	Total Variation of Vcross	Over all edges		140	mV	2
T <sub>DC</sub>	Duty Cycle	OUT[0:3] & OUT[0:3]#	45	55	%	3
T <sub>jadd</sub>	Additive RMS phase jitter	For PCIe 2.0	<0	1	ps	5

#### **HCSL Output AC Switching Characteristics** ( $V_{DD} = 3.3\pm5\%$ , $V_{DD} = 3.3\pm5\%$ )

Notes:

Test configuration is  $R_s = 33.2\Omega$ ,  $Rp = 49.9\Omega$ , and 2pF. 1.

Measurement taken from Single Ended waveform. 2.

Measurement taken from Differential waveform. 3.

4. Measurement taken using M1 data capture analysis tool.

Additive jitter is calculated from input and output RMS phase jitter by using PCIe 2.0 filter.  $(T_{jadd} = \sqrt{(output jitter)^2 - (input jitter)^2})$ 5.

Using the test configuration and data is taken at the probe pads 6.



#### **Figure 4. Test Configuration**





# **Application Information**

#### **Termination for DC-Coupled Differential Operation**

For DC-coupled operation of an HCSL driver, terminate with 50  $\Omega$  to ground near the driver output as shown in Figure 5. Series resistors, Rs, are used to limit overshoot due to the fast transient current. Because HCSL drivers require a DC path to ground, AC coupling is not allowed between the output drivers and the  $50\Omega$  termination resistors.



Figure 5. DC Coupled HCSL Operation

#### **Termination for AC-Coupled Differential Operation**

AC coupling allows for shifting the DC bias level (common-mode voltage) when driving different receiver standards. Because ACcoupling prevents the driver from providing a DC bias voltage at the receiver, it is important to ensure the receiver is biased to its ideal DC level. The PI6C20400A does not have an internal DC bias, therefore an external DC bias circuit to around 350mV is needed when PI6C20400A is the receiver in the AC-coupled operation.





# **Part Marking**

L Package	H Package
PI6C	PI6C
20400ALE	20400AHE
YYYWWXX	YYWWXX
Y: Die Rev	O
YY: Year	YY: Year
WW: Workweek	WW: Workweek
1st X: Assembly Code	1st X: Assembly Code
2nd X: Fab Code	2nd X: Fab Code





NOM.

\_\_\_

\_\_\_

1.75

\_\_\_

0.30

\_\_\_

0.15

7.80

\_\_\_

4°

5.30 5.60

MAX.

2.0

\_\_\_

1.85

0.38

0.33

0.25

0.21

8.20

\_\_\_

8°

DATE: 04/10/08

**REVISION: F** 

# **Packaging Mechanical**



08-0143

2. Ref.: JEDEC MS-150B/AH

3. Package Outline Exclusive of Mold Flash and Metal Burr

DESCRIPTION: 28-Pin, 209-Mil Wide, SSOP

DOCUMENT CONTROL #: PD-1250

PACKAGE CODE: H28





28-TSSOP (L)



#### For latest package info.

please check: http://www.diodes.com/design/support/packaging/pericom-packaging/packaging-mechanicals-and-thermal-characteristics/

# **Ordering Information**

Ordering Code	Package Code	Package Description
PI6C20400AHEX	Н	28-pin, 209-mil wide (SSOP)
PI6C20400ALEX	L	28-pin, 173-mil wide (TSSOP)

Notes:

1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free. 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. E = Pb-free and Green

5. X suffix = Tape/Reel





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